## Application/Control No. Applicant(s)/Patent Under Reexamination 10/750,355 MATHIEU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Edwin A. León 2833 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY 05-1994 \* US-5,308,252 Mroczkowski et al. 439/66 Α US-В US-С US-D US-Ε US-F US-G US-Н USt US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date **Classification** Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** \* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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